

<b>Notice of References Cited</b>	Application/Control No. 10/566,915	Applicant(s)/Patent Under Reexamination KONISHI ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0086803	07-2002	Berlowitz et al.	508/371
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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